

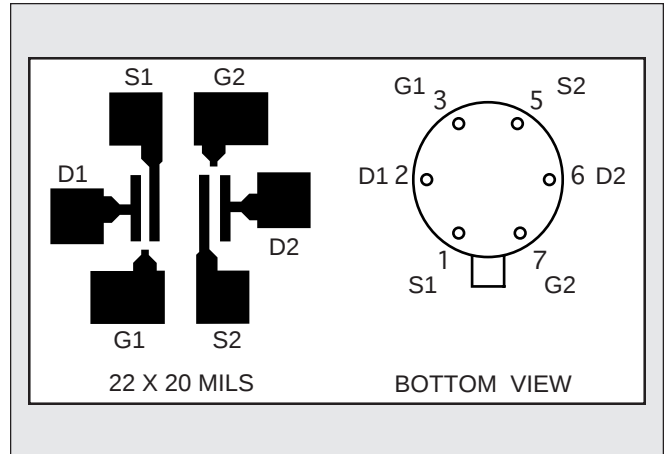
LINEAR SYSTEMS

Linear Integrated Systems

FEATURES		
ULTRA LOW DRIFT	$ \Delta V_{GS1-2} / \Delta T = 5\mu V/^{\circ}C$ max.	
ULTRA LOW LEAKAGE	$I_G = 80fA$ TYP.	
LOW NOISE	$e_n = 70nV/\sqrt{Hz}$ TYP.	
LOW CAPACITANCE	$C_{ISS} = 3pf$ MAX.	
ABSOLUTE MAXIMUM RATINGS <u>NOTE 1</u>		
@ 25°C (unless otherwise noted)		
Maximum Temperatures		
Storage Temperature	-65° to +150°C	
Operating Junction Temperature	+150°C	
Maximum Voltage and Current for Each Transistor <u>NOTE 1</u>		
-V _{GSS}	Gate Voltage to Drain or Source	40V
-V _{DSO}	Drain to Source Voltage	40V
-I _{G(f)}	Gate Forward Current	10mA
-I _G	Gate Reverse Current	10μA
Maximum Power Dissipation		
Device Dissipation @ Free Air - Total		40mW @ +125°C

LS830 LS831 LS832 LS833

ULTRA LOW LEAKAGE LOW DRIFT
MONOLITHIC DUAL N-CHANNEL JFET



ELECTRICAL CHARACTERISTICS @ 25°C (unless otherwise noted)

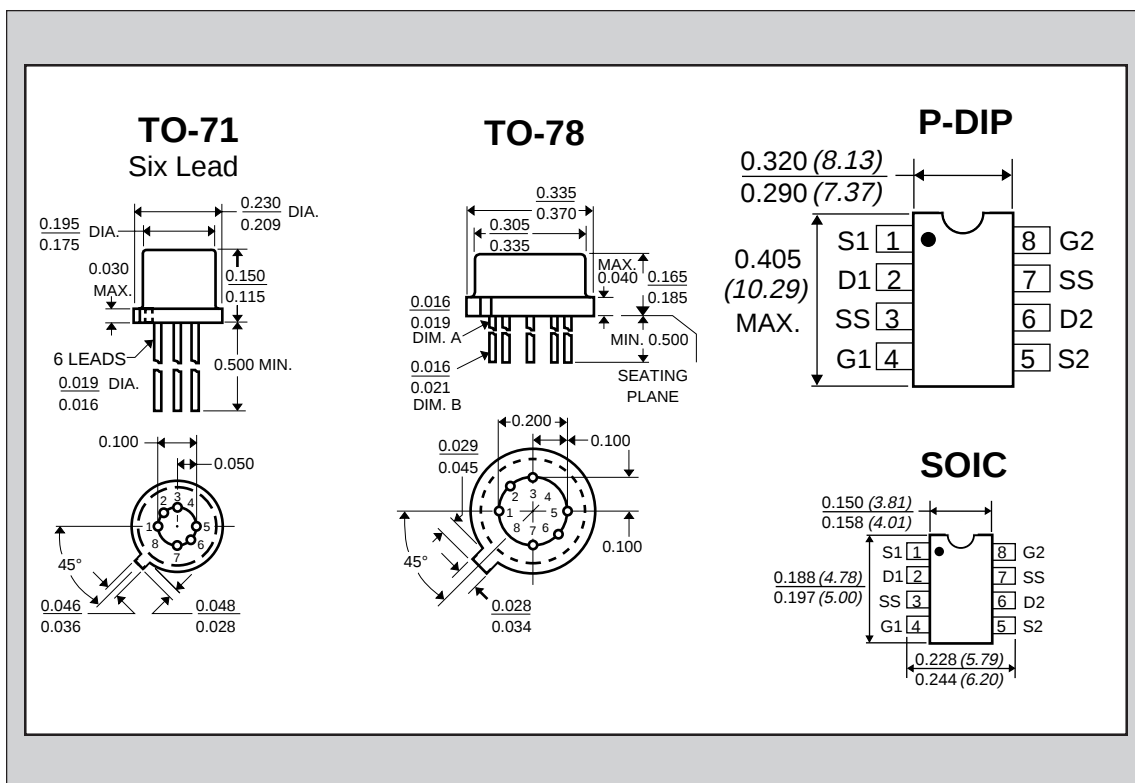
SYMBOL	CHARACTERISTICS	LS830	LS831	LS832	LS833	UNITS	CONDITIONS
$ \Delta V_{GS1-2} / \Delta T $ max.	Drift vs. Temperature	5	10	20	75	$\mu V/^{\circ}C$	$V_{DG} = 10V$ $I_D = 30 \mu A$ $T_A = -55^{\circ}C$ to $+125^{\circ}C$
$ V_{GS1-2} $ max.	Offset Voltage	25	25	25	25	mV	$V_{DG} = 10V$ $I_D = 30 \mu A$
$-I_G$ max	Operating	0.1	0.1	0.1	0.5	pA	$T_A = +125^{\circ}C$
$-I_G$ max	High Temperature	0.1	0.1	0.1	0.5	nA	
$-I_{GSS}$	At Full Conduction	0.2	0.2	0.2	1.0	pA	$V_{GS} = 0$ $V_{GS} = -20V$ $T_A = +125^{\circ}C$
$-I_{GSS}$	High Temperature	0.5	0.5	0.5	1.0	nA	

SYMBOL	CHARACTERISTICS	MIN.	TYP.	MAX.	UNITS	CONDITIONS
BV_{GSS}	Breakdown Voltage	40	60	--	V	$V_{DS} = 0$ $I_D = 1 nA$
BV_{GGO}	Gate-to-Gate Breakdown	40	--	--	V	$I_G = 1 nA$ $I_D = 0$ $I_S = 0$
Y_{fss}	TRANSCONDUCTANCE Full Conduction	70	300	500	μmho	$V_{DG} = 10V$ $V_{GS} = 0$ $f = 1 kHz$
Y_{fs}	Typical Operation	50	100	200	μmho	$V_{DG} = 10V$ $I_D = 30 \mu A$ $f = 1 kHz$
$ Y_{fs1-2} / Y_{fs} $	Mismatch	--	1	5	%	
I_{DSS}	DRAIN CURRENT Full Conduction	60	400	1000	μA	$V_{DG} = 10V$ $V_{GS} = 0$
$ I_{DSS1-2} / I_{DSS} $	Mismatch at Full Conduction	--	2	5	%	
$V_{GS(off)}$ or V_P	GATE VOLTAGE Pinchoff Voltage	0.6	2	4.5	V	$V_{DS} = 10V$ $I_D = 1 nA$
V_{GS}	Operating Range	--	--	4	V	$V_{DG} = 10V$ $I_D = 30 \mu A$
I_{GGO}	GATE CURRENT Gate-to-Gate Leakage	--	1	--	pA	$V_{GG} = 20V$

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SYMBOL	CHARACTERISTICS	MIN.	TYP.	MAX.	UNITS	CONDITIONS
OUTPUT CONDUCTANCE						
Y_{oss}	Full Conduction	--	--	5	μmho	$V_{DG} = 10\text{V}$ $V_{GS} = 0$
Y_{os}	Operating	--	--	0.5	μmho	$V_{DG} = 10\text{V}$ $I_D = 30\mu\text{A}$
$ Y_{os1-2} $	Differential	--	--	0.1	μmho	
COMMON MODE REJECTION						
CMR	$-20 \log \Delta V_{GS1-2} / \Delta V_{DS} $	--	90	--	dB	$\Delta V_{DS} = 10 \text{ to } 20\text{V}$ $I_D = 30\mu\text{A}$
CMR	$-20 \log \Delta V_{GS1-2} / \Delta V_{DS} $	--	90	--	dB	$\Delta V_{DS} = 5 \text{ to } 10\text{V}$ $I_D = 30\mu\text{A}$
NOISE						
NF	Figure	--	--	1	dB	$V_{DS} = 10\text{V}$ $V_{GS} = 0$ $R_G = 10\text{M}\Omega$ $f = 100\text{Hz}$ NBW= 6Hz
e_n	Voltage	--	20	70	$\text{nV}/\sqrt{\text{Hz}}$	$V_{DG} = 10\text{V}$ $I_D = 30\mu\text{A}$ $f = 10\text{Hz}$ NBW= 1Hz
CAPACITANCE						
C_{ISS}	Input	--	--	3	pF	$V_{DS} = 10\text{V}$ $V_{GS} = 0$ $f = 1\text{MHz}$
C_{RSS}	Reverse Transfer	--	--	1.5	pF	$V_{DS} = 10\text{V}$ $V_{GS} = 0$ $f = 1\text{MHz}$
C_{DD}	Drain-to-Drain	--	--	0.1	pF	$V_{DG} = 10\text{V}$ $I_D = 30\mu\text{A}$



NOTES:

1. These ratings are limiting values above which the serviceability of any semiconductor may be impaired.